

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/715,964	AOKI, NORIHIRO EDWIN	
Examiner		Art Unit		Page 1 of 1
Sunray Chang		2121		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,564,264	05-2003	Creswell et al.	709/245
*	B	US-2002/0143879	10-2002	Sommerer, Peter	709/206
*	C	US-2003/0131005	07-2003	Berry, Richard Edmond	707/10
*	D	US-2004/0267625	12-2004	Feng et al.	705/026
*	E	US-6,654,779	11-2003	Tsuei, Henry T.	718/101
*	F	US-5,742,668	04-1998	Pepe et al.	455/415
*	G	US-2002/0023138	02-2002	Quine et al.	709/206
*	H	US-6,438,583	08-2002	McDowell et al.	709/206
*	I	US-2002/0178074	11-2002	Bloom, Gregg	705/26
*	J	US-2003/0120733	06-2003	Forman, George H.	709/206
*	K	US-6,457,012	09-2002	Jatkowski, Paul	707/101
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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